

MOSFETs Silicon N-channel MOS (U-MOSVII-H)

SSM3K341R

1. Applications

- · Power Management Switches
- · DC-DC Converters

2. Features

- (1) AEC-Q101 qualified (Note 1)
- (2) 175 °C MOSFET
- (3) 4.0 V drive
- (4) Low drain-source on-resistance
 - : $R_{DS(ON)}$ = 28 m Ω (typ.) (@ V_{GS} = 10 V)

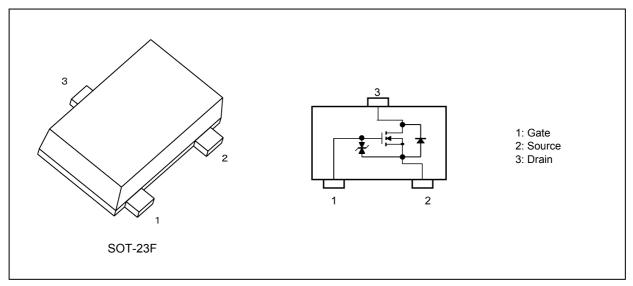
$$R_{\rm DS(ON)} = 36 \ {\rm m}\Omega \ ({\rm typ.}) \ (@V_{\rm GS} = 4.5 \ {\rm V})$$

$$R_{\mathrm{DS(ON)}} = 43 \ \mathrm{m}\Omega \ (\mathrm{typ.}) \ (@V_{\mathrm{GS}} = 4 \ \mathrm{V})$$

(5) HBM: 2-kV class

Note 1: For detail information, please contact to our sales.

3. Packaging and Pin Assignment





4. Absolute Maximum Ratings (Note) (Unless otherwise specified, Ta = 25 °C)

Characteristics	Symbol	Rating	Unit		
Drain-source voltage			V_{DSS}	60	V
Gate-source voltage			V_{GSS}	±20	
Drain current (DC)		(Note 1)	I_D	6	Α
Drain current (pulsed)		(Note 1), (Note 2)	I_{DP}	24	
Power dissipation		(Note 3)	P_D	1.2	W
Power dissipation	(t = 10 s)	(Note 3)	P_{D}	2.4	
Single-pulse avalanche energy		(Note 4)	E _{AS}	28.9	mJ
Avalanche current			I _{AR}	6	Α
Channel temperature		(Note 5)	T _{ch}	175	°C
Storage temperature		(Note 5)	T _{stg}	-55 to 175	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 1: Ensure that the channel temperature does not exceed 175 °C.
- Note 2: pulse width \leq 1 ms, Duty \leq 1 %
- Note 3: Device mounted on a 25.4 mm × 25.4 mm × 1.6 mm FR4 glass epoxy board (Cu pad: 645 mm²)
- Note 4: V_{DD} = 25 V, T_{ch} = 25 °C (Initial state), L = 1 mH, R_G = 25 Ω
- Note 5: The definitions of the absolute maximum channel and storage temperatures are qualified per AEC-Q101.
- Note: This transistor is sensitive to electrostatic discharge and should be handled with care.
- Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.
- Note: The channel-to-ambient thermal resistance, R_{th(ch-a)}, and the drain power dissipation, P_D, vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.

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5. Electrical Characteristics

5.1. Static Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	V _{GS} = ±16 V	_	_	±10	μА
Drain cut-off current		I _{DSS}	V _{DS} = 60 V	_		1	
Drain-source breakdown voltage		V _{(BR)DSS}	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	60	_		V
Drain-source breakdown voltage	(Note 1)	V _{(BR)DSX}	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	40	_		
Gate threshold voltage	(Note 2)	V_{th}	$V_{DS} = 10 \text{ V}, I_{D} = 0.1 \text{ mA}$	1.5		2.5	
Drain-source on-resistance	(Note 3)	R _{DS(ON)}	I _D = 2 A, V _{GS} = 4 V	_	43	69	mΩ
			I _D = 3 A, V _{GS} = 4.5 V	_	36	51	
			I _D = 5 A, V _{GS} = 10 V	_	28	36	

Note 1: If a reverse bias is applied between gate and source, this device enters $V_{(BR)DSX}$ mode. Note that the drain-source breakdown voltage is lowered in this mode.

Note 2: Let V_{th} be the voltage applied between gate and source that causes the drain current (I_D) to below (0.1 mA for this device). Then, for normal switching operation, $V_{GS(ON)}$ must be higher than V_{th} , and $V_{GS(OFF)}$ must be lower than V_{th} . This relationship can be expressed as: $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$.

Take this into consideration when using the device.

Note 3: Pulse measurement.

5.2. Dynamic Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C _{iss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$	_	550	_	pF
Reverse transfer capacitance	C _{rss}	f = 1 MHz	_	35		
Output capacitance	Coss		_	300	_	
Switching time (rise time)	t _r	$V_{DD} = 30 \text{ V}, I_D = 3 \text{ A},$	_	48	_	ns
Switching time (turn-on time)	t _{on}	V_{GS} = 0 to 4.5 V, R_{G} = 50 Ω Duty \leq 1 %,Input: t_{r} , t_{f} < 5 ns,	_	63	_	
Switching time (fall time)	t _f	Common source,	_	6	_	
Switching time (turn-off time)	t _{off}	See Chapter 5.3.	_	18		

5.3. Switching Time Test Circuit

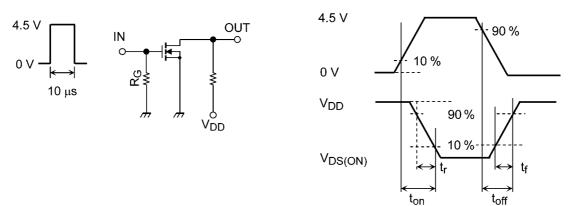


Fig. 5.3.1 Switching Time Test Circuit

Fig. 5.3.2 Input Waveform/Output Waveform

5.4. Gate Charge Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	Qg	$V_{DD} = 48 \text{ V}, I_D = 2 \text{ A},$	_	9.3		nC
Gate-source charge 1	Q _{gs1}	V _{GS} = 10 V	_	1.8		
Gate-drain charge	Q _{gd}		_	2.0		

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5.5. Source-Drain Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage	(Note 1)	V_{DSF}	I _D = -6 A, V _{GS} = 0 V	_	-0.9	-1.5	V

Note 1: Pulse measurement.

6. Marking

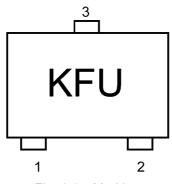


Fig. 6.1 Marking

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7. Characteristics Curves (Note)

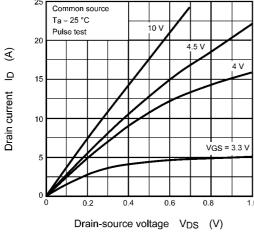


Fig. 7.1 I_D - V_{DS}

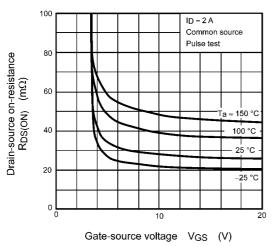


Fig. 7.3 R_{DS(ON)} - V_{GS}

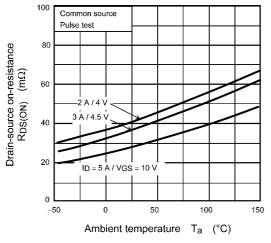


Fig. 7.5 R_{DS(ON)} - T_a

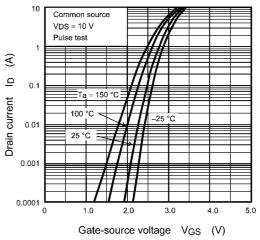


Fig. 7.2 I_D - V_{GS}

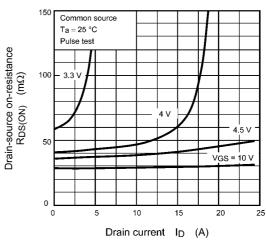


Fig. 7.4 R_{DS(ON)} - I_D

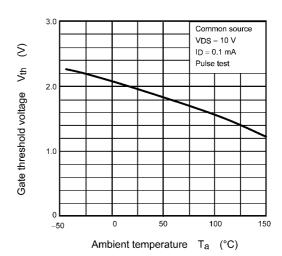


Fig. 7.6 V_{th} - T_a



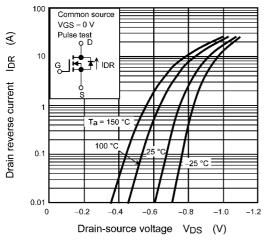


Fig. 7.7 IDR - VDS

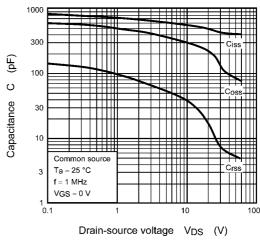


Fig. 7.8 C - V_{DS}

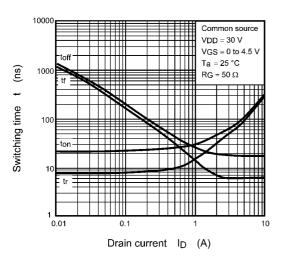


Fig. 7.9 t - I_D

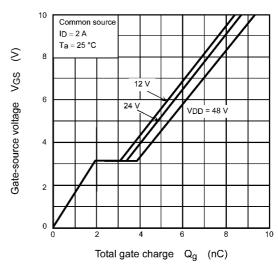


Fig. 7.10 Dynamic Input Characteristics

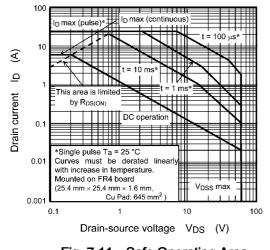


Fig. 7.11 Safe Operating Area

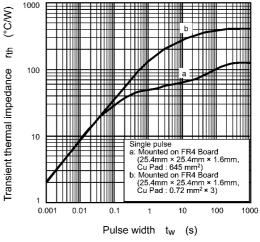
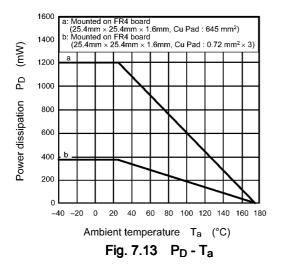


Fig. 7.12 r_{th} - t_w





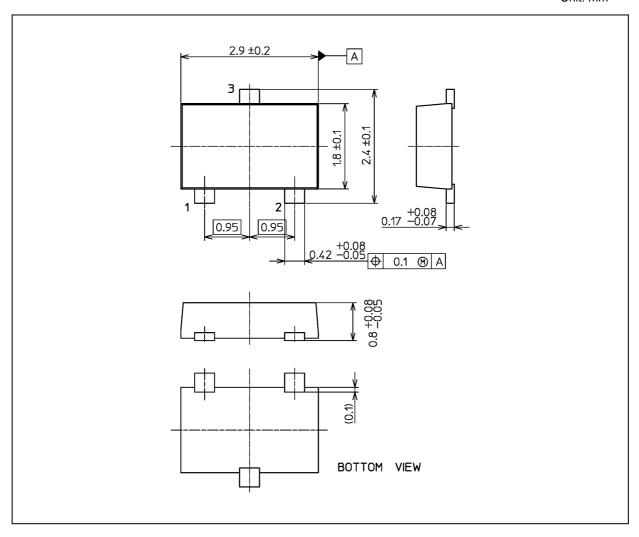
Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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Package Dimensions

Unit: mm



Weight: 0.011 g (typ.)

	Package Name(s)
TOSHIBA: 2-3Z1S	
Nickname: SOT-23F	

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